

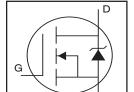


Features

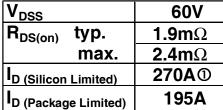
- Advanced Process Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



HEXFET® Power MOSFET





G	D	S
Gate	Drain	Source

Bass Bast Namelan	Daalsana Tuma	Standard Pa	ck	Oudevable Dout Novebox	
Base Part Number	Package Type	Form	Quantity	Orderable Part Number	
		Tube	50	AUIRLS3036	
AUIRLS3036	D2-Pak	Tape and Reel Left	800	AUIRLS3036TRL	
		Tape and Reel Right	800	AUIRLS3036TRR	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	270①	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	190	
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	195] ^
I _{DM}	Pulsed Drain Current ②	1100	
P _D @T _C = 25°C	Maximum Power Dissipation	380	W
	Linear Derating Factor	2.5	W/°C
V_{GS}	Gate-to-Source Voltage	±16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 3	290	mJ
I _{AR}	Avalanche Current ②	Con Fig. 14, 15, 000, 00b	Α
E _{AR}	Repetitive Avalanche Energy ®	See Fig. 14, 15, 22a, 22b	mJ
dv/dt	Peak Diode Recovery ④	8.0	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range	-55 10 + 175	- °C
	Soldering Temperature, for 10 seconds	300] [
	(1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 9 (1)		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount, steady state) ®		40	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/



Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.061		V/°C	Reference to 25°C, I _D = 5mA
D	Static Drain-to-Source On-Resistance		1.9	2.4	mO	$V_{GS} = 10V, I_D = 165A $ ⑤
R _{DS(on)}	Static Drain-to-Source Off-nesistance		2.2	2.8	mΩ	$V_{GS} = 4.5V, I_{D} = 140A \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	340			S	$V_{DS} = 10V, I_{D} = 165A$
R _{G(int)}	Internal Gate Resistance		2.0		Ω	
I _{DSS}	Drain-to-Source Leakage Current			20		$V_{DS} = 60V, V_{GS} = 0V$
				250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	n 1	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		91	140		I _D = 165A
Q_{gs}	Gate-to-Source Charge	_	31			$V_{DS} = 30V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	_	51		nC	V _{GS} = 4.5V ⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})	_	40			$I_D = 165A, V_{DS} = 0V, V_{GS} = 4.5V$
t _{d(on)}	Turn-On Delay Time	_	66			$V_{DD} = 39V$
t _r	Rise Time	_	220		1	I _D = 165A
t _{d(off)}	Turn-Off Delay Time	_	110		ns	$R_G = 2.1\Omega$
t _f	Fall Time		110			V _{GS} = 4.5V ⑤
C _{iss}	Input Capacitance	_	11210			$V_{GS} = 0V$
C _{oss}	Output Capacitance	_	1020			$V_{DS} = 50V$
C _{rss}	Reverse Transfer Capacitance	_	500		pF	f = 1.0MHz
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)	_	1430			$V_{GS} = 0V$, $V_{DS} = 0V$ to 48V \bigcirc
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		1880			V _{GS} = (V, V_{DS} - ovice for a

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			270 ①		MOSFET symbol
	(Body Diode)			2700	_	showing the
I _{SM}	Pulsed Source Current			1100	A	integral reverse
	(Body Diode) 3			1100		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 165A$, $V_{GS} = 0V$ \odot
t _{rr}	Reverse Recovery Time		62			$T_J = 25$ °C $V_R = 51V$,
			66		ns	$T_{\rm J} = 125^{\circ}{\rm C}$ $I_{\rm F} = 165{\rm A}$
Q _{rr}	Reverse Recovery Charge		310		n n('	$T_J = 25^{\circ}C$ di/dt = 100A/ μ s $^{\circ}$
			360			$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		4.4		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

- ① Calcuted continuous current based on maximum allowable junction temperature Bond wire current limit is 195A. Note that current limitation arising from heating of the device leds may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\ \, \ \, \ \,$ Limited by T_{Jmax}, starting T_J = 25°C, L = 0.021mH R_G = 25 Ω , I_{AS} = 165A, V_{GS} =10V. Part not recommended for use above this value .
- ⓐ $I_{SD} \le 165A$, di/dt ≤ 430A/ μ s, $V_{DD} \le V_{(BR)DSS}$, $T_{J} \le 175$ °C.
- ⑤ Pulse width ≤ 400µs; duty cycle ≤ 2%.

- $^{\circ}$ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniquea refer to application note # AN- 994 echniques refer to application note #AN-994.
- Limited by TJmax, see Fig. 14, 15, 22a, 22b for typical repetitive avalanche performance.
- $^{\odot}$ R_{θ JC} value shown is at time zero.



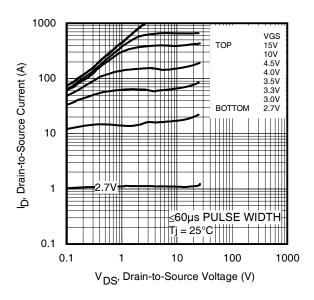


Fig 1. Typical Output Characteristics

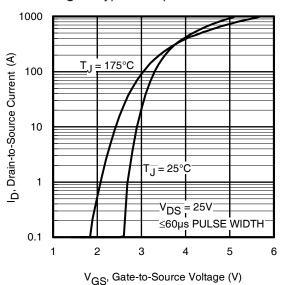


Fig 3. Typical Transfer Characteristics

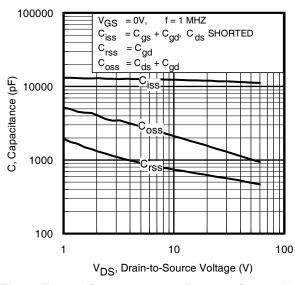


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

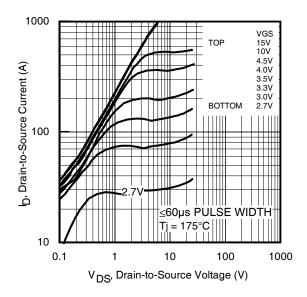


Fig 2. Typical Output Characteristics

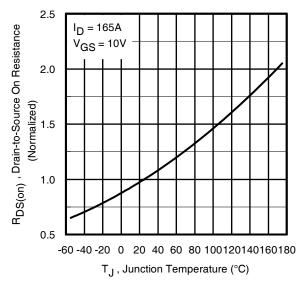


Fig 4. Normalized On-Resistance vs. Temperature

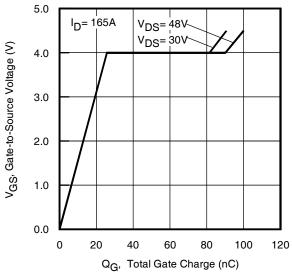


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

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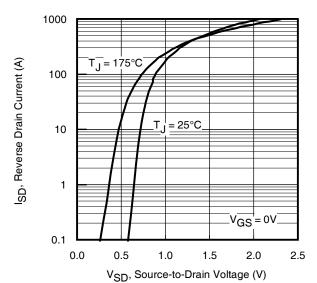
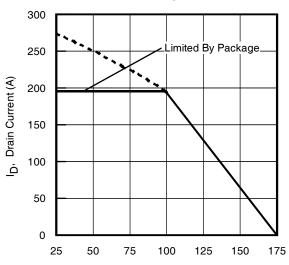
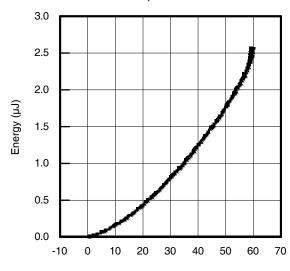


Fig 7. Typical Source-Drain Diode Forward Voltage



T_C , Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} \text{V}_{DS,} \, \text{Drain-to-Source Voltage (V)} \\ \textbf{Fig 11.} \, \, \text{Typical C}_{OSS} \, \text{Stored Energy}$

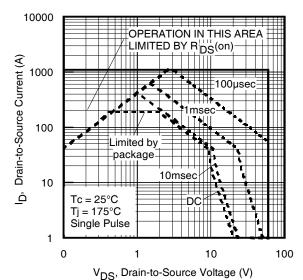


Fig 8. Maximum Safe Operating Area

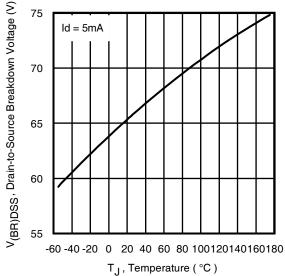


Fig 10. Drain-to-Source Breakdown Voltage

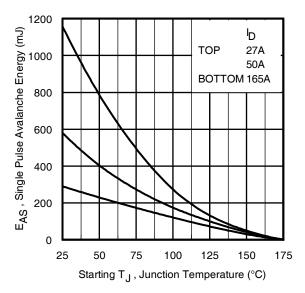


Fig 12. Maximum Avalanche Energy vs. DrainCurrent



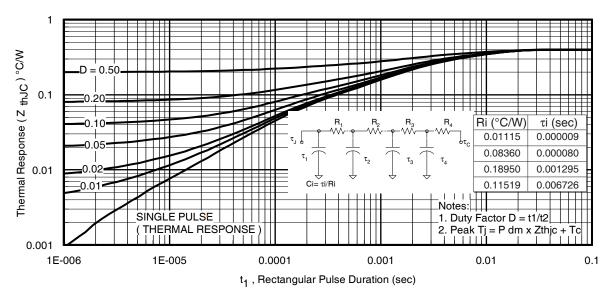


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

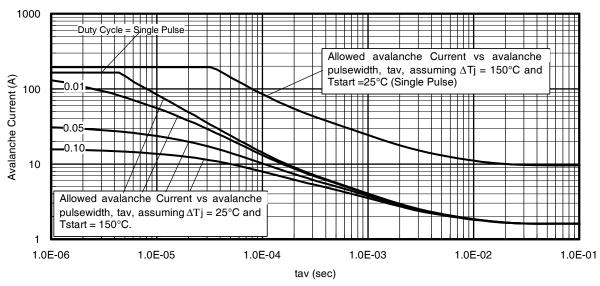


Fig 14. Typical Avalanche Current vs. Pulsewidth

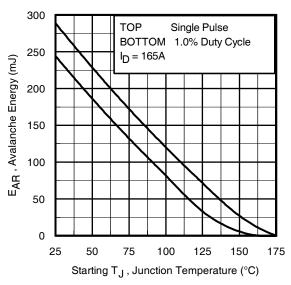


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

 $P_{D \; (ave)}$ = 1/2 (1.3·BV·I $_{av})$ = $\triangle T / \; Z_{thJC}$ $I_{av} = 2\Delta T/ [1.3 \cdot BV \cdot Z_{th}]$ $E_{AS (AR)} = P_{D (ave)} \cdot t_{av}$



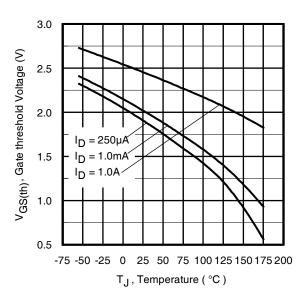


Fig 16. Threshold Voltage vs. Temperature

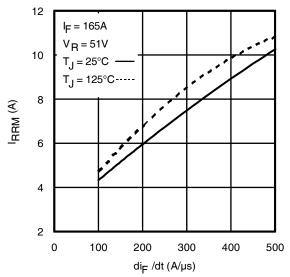


Fig. 18 - Typical Recovery Current vs. di_f/dt

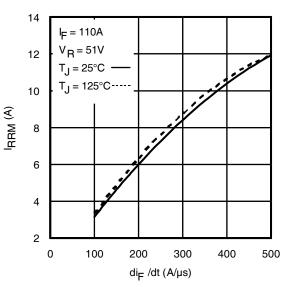


Fig. 17 - Typical Recovery Current vs. di_f/dt

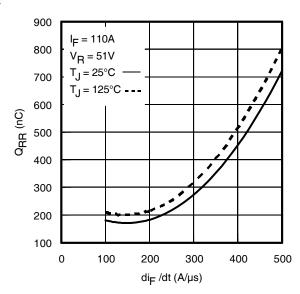


Fig. 19 - Typical Stored Charge vs. di_f/dt

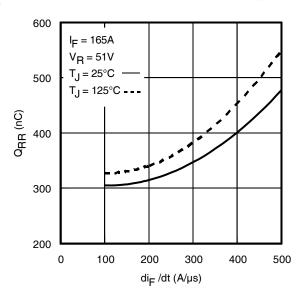


Fig. 20 - Typical Stored Charge vs. di_f/dt

V_{GS}=10V

 V_{DD}

 I_{SD}



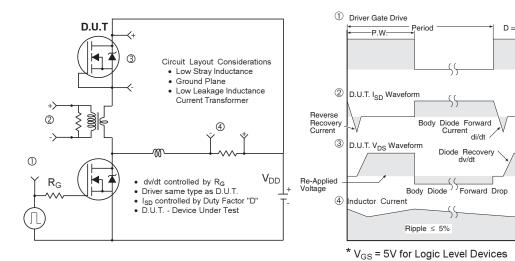


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

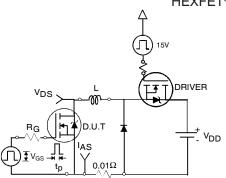


Fig 22a. Unclamped Inductive Test Circuit

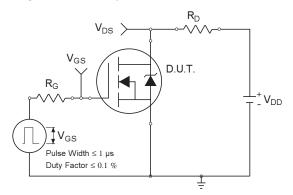


Fig 23a. Switching Time Test Circuit

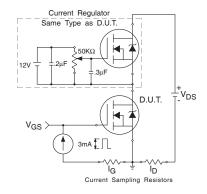


Fig 24a. Gate Charge Test Circuit

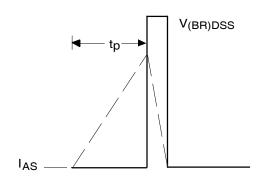


Fig 22b. Unclamped Inductive Waveforms

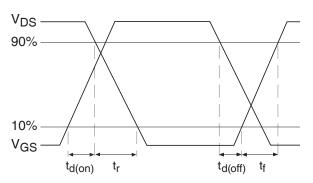


Fig 23b. Switching Time Waveforms

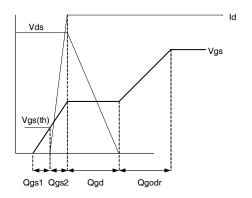
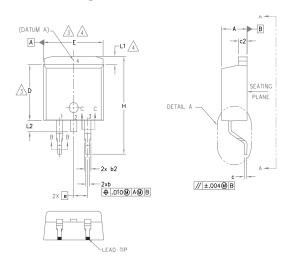
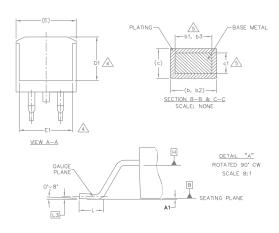


Fig 24b. Gate Charge Waveform



D²Pak Package Outline (Dimensions are shown in millimeters (inches))





S Y M		N			
l B	MILLIM	ETERS	INC	HES	O T E S
0	MIN.	MAX.	MIN.	MAX,	S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	,020	.039	
b1	0.51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10,67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14,61	15,88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- MOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
 - 7. CONTROLLING DIMENSION: INCH.
 - 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE

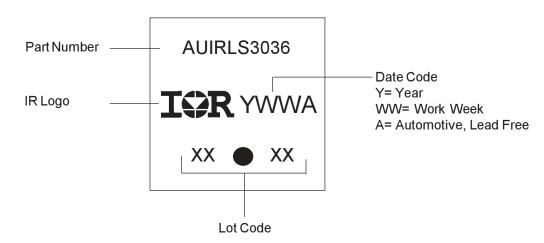
3.- ANODE

HEXEET

IGBTs, CoPACK

2, 4,- DRAIN 3.- SOURCE 1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

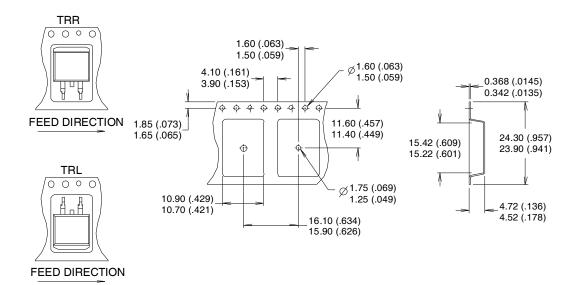
D²Pak Part Marking Information

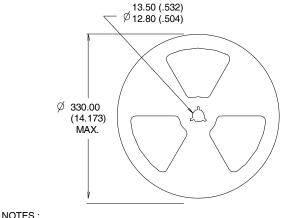


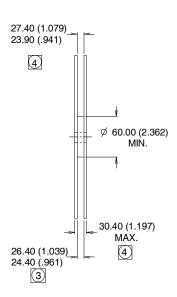
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak Tape & Reel Information







NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- 4 INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information[†]

			Automotive				
			(per AEC-Q101) ^{††}				
Qualification Level		qualification.	This part number(s) passed Automotive IR's Industrial and Consumer qualification level extension of the higher Automotive level.				
Moisture Sensitivit	Moisture Sensitivity Level		MSL1				
	Machine Model		Class M4 (+/- 800V)†††				
		AEC-Q101-002					
	Human Body Model	Class H3A (+/- 6000V) ^{†††}					
ESD			AEC-Q101-001				
	Charged Device Model		Class C5 (+/- 2000V) ^{†††}				
			AEC-Q101-005				
RoHS Compliant			Yes				

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

^{†††} Highest passing voltage.



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WORLD HEADQUARTERS:

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Revision History

Date	Comments				
4/2/2014	Added "Logic Level Gate Drive" bullet in the features section on page 1 Updated package outline on page 8 Updated typo on the fig.19 and fig.21, unit of y-axis from "A" to "nC" on page 6. Updated data sheet with new IR corporate template				